## Applicant(s)/Patent Under Reexamination Application/Control No. 09/775,018 SUDER ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 2668 Hanh Nguyen

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,678,280 b1	01-2004	Kim et al.	370/429
	В	US-6,839,341 b1	01-2005	Nakajima, Yasunori	370/352
	O	US-6,876,648 b1	04-2005	Lee, Dae-Jin	370/353
	۵	US-5,751,791	05-1998	Chen et al.	379/88.13
	ш	US-5,878,120	03-1999	O'Mahony, Barry	379/93.09
	F	US-6,798,768 b1	09-2004	Gallick et al.	370/352
	G	US-			
	Н	US-	122		
	1	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
	٦							
	٧							
	w							
	x							

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.